## Notice of References Cited Application/Control No. 10/579,193 Examiner Bryan P. Gordon Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,267,796	12-1993	Nonaka et al.	384/8
	В	US-			
	С	US-			
	D	US-		-	
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-	1 = = -1		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 06006989	01-1994	Japan	Tomoki	
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	Р					
	Q					·
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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